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Universal serial bus interfaces for data and power –
Part 1-4: Common components – USB Type-C™ Authentication Specification
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Interfaces de bus universel en série pour les données et l'alimentation
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Partie 1-4: Composants communs – Spécification relative à l'authentification
USB Type-C™





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Part 1-4: Common components – USB Type-C™ Authentication Specification

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The text of this standard was prepared by the USB Implementers Forum (USB-IF). The structure and editorial rules used in this publication reflect the practice of the organization which submitted it.

This bilingual version (2019-01) corresponds to the English version, published in 2018-04.

The text of this International Standard is based on the following documents:

CDV	Report on voting
100/2981/CDV	100/3046/RVC

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

The French version of this standard has not been voted upon.

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The IEC 62680 series is based on a series of specifications that were originally developed by the USB Implementers Forum (USB-IF). These specifications were submitted to the IEC under the auspices of a special agreement between the IEC and the USB-IF.

This standard is the USB-IF publication USB Type-C™ Authentication Specification Revision 1.0.

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Revision 1.0 with ECN and Errata through February 2, 2017
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